

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10521563	KNEBEL ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Logie, Michael J	2881

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
250	309	7/30/2007	ml
250	423F	7/30/2007	ml
250	307	7/30/2007	ml
250	288	7/30/2007	ml
250	306	7/30/2007	ml
250	287	7/30/2007	ml
73	104-105	7/30/2007	ml
250	282, 288	1/25/2008	ml

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST(US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)--See search notes	7/27/2007	ml
EAST(US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)--See search notes	7/30/2007	ml
EAST(US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)--See search notes	7/31/2007	ml
EAST(US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)--See search notes	1/25/2008	ml

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>